

Application/Control No.	Applicant(s)/Patent und Reexamination	er
10/823,664	AKASAKI ET AL.	
Examiner	Art Unit	
VanThu Nguyen	2824	

SEARCHED					
Class	Subclass	Date	Examiner		
365	194 o 189.05 189.08 225.7 233	9/29/2005	VTN		
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TAI	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST Search (see print out history)	9/29/2005	VTN		